Search Notes

Application/Control No.	Applicant(s)/Patent unde Reexamination
10/651,585	TATMAN, LANCE A.
Examiner	Art Unit

John M. Frink

2142

SEARCHED					
Class	Subclass	Date	Examiner		
					
					
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INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
		DATE	EXMR
subclass + text	:	5/17/2007	JMF
inventor		5/17/2007	JMF
assignee + text	. :	5/17/2007	JMF
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